

<b>Notice of References Cited</b>	Application/Control No. 10/663,121	Applicant(s)/Patent Under Reexamination SEELIG ET AL.	
	Examiner Milap Shah	Art Unit 3712	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,621,815	11-1986	Yamamoto, Toshio	273/143R
	B	US-5,209,477	05-1993	Heidel et al.	273/143R
	C	US-5,284,344	02-1994	Howard, Terence	273/143R
	D	US-6,811,273	11-2004	Satoh et al.	362/27
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2001353255 A	12-2001	Japan	HARUTA, MASAHIKO	
	O	JP 2001062032 A	03-2001	Japan	YAMAGUCHI et al.	
	P	JP 2001087458 A	04-2001	Japan	IKEDA et al.	
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	English Translation of JP 2001-353255 A, including Abstract & Detailed Description. Retrieved from JPO. [online] [retrieved 2006-04-15] <URL:http://www.jpo.go.jp/>.
	V	English Translation of JP 2001-062032 A, including Abstract & Detailed Description. Retrieved from JPO. [online] [retrieved 2006-04-15] <URL:http://www.jpo.go.jp/>.
	W	English Translation of JP 2001-087458 A, including Abstract & Detailed Description. Retrieved from JPO. [online] [retrieved 2006-04-15] <URL:http://www.jpo.go.jp/>.
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.